Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/829,189	Reexamination HAYASHI, YOSH	IKAZU
Examiner	Art Unit	
OLUGBENGA O. IDOWU	2425	Page 1 of 1

U.S. PATENT DOCUMENTS

	O.S. I ATEN DOCUMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0157115 A1	10-2002	Lu, Jin	725/131
*	В	US-6,714,262 B1	03-2004	Tsurumi, Atsushi	348/731
*	O	US-2004/0086127 A1	05-2004	Candelore, Brant L.	380/281
*	D	US-6,751,197 B1	06-2004	Sadanaka, Nobuyuki	370/252
*	Е	US-2005/0144646 A1	06-2005	Lecrom et al.	725/100
*	F	US-2005/0144651 A1	06-2005	Prus et al.	725/134
	G	US-		-	
	н	US-		-	
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN FATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS

*	NON-AIEN DOCUMENTS			
-		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	w			
	x			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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